


<b>Search Notes</b>  	<b>Application/Control No.</b>  10571467	<b>Applicant(s)/Patent Under Reexamination</b>  MISAWA ET AL.
	<b>Examiner</b>  M. Lee	<b>Art Unit</b>  2622

SEARCHED			
Class	Subclass	Date	Examiner
348	705, 706, 731, 725, 730, 554, 555	3/24/09	ml
455	151.1, 153.1 153.2	3/24/09	ml

SEARCH NOTES			
Search Notes		Date	Examiner
east		3/24/09	ml

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	Interference search history attached.	3/24/09	ml

	/M. Lee/ Primary Examiner.Art Unit 2622
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